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Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details

Product Status	Obsolete
Number of LABs/CLBs	1694
Number of Logic Elements/Cells	33880
Total RAM Bits	1369728
Number of I/O	500
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	672-BBGA
Supplier Device Package	672-FBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep2s30f672c5

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Chapter Revision Dates

The chapters in this book, *Stratix II Device Handbook, Volume 1*, were revised on the following dates. Where chapters or groups of chapters are available separately, part numbers are listed.

- Chapter 1. Introduction
 - Revised: *May 2007*
 - Part number: *SII51001-4.2*

- Chapter 2. Stratix II Architecture
 - Revised: *May 2007*
 - Part number: *SII51002-4.3*

- Chapter 3. Configuration & Testing
 - Revised: *May 2007*
 - Part number: *SII51003-4.2*

- Chapter 4. Hot Socketing & Power-On Reset
 - Revised: *May 2007*
 - Part number: *SII51004-3.2*

- Chapter 5. DC & Switching Characteristics
 - Revised: *April 2011*
 - Part number: *SII51005-4.5*

- Chapter 6. Reference & Ordering Information
 - Revised: *April 2011*
 - Part number: *SII51006-2.2*

Document Revision History

Table 1–6 shows the revision history for this chapter.

Date and Document Version	Changes Made	Summary of Changes
May 2007, v4.2	Moved Document Revision History to the end of the chapter.	—
April 2006, v4.1	<ul style="list-style-type: none"> ● Updated “Features” section. ● Removed Note 4 from Table 1–2. ● Updated Table 1–4. 	—
December 2005, v4.0	<ul style="list-style-type: none"> ● Updated Tables 1–2, 1–4, and 1–5. ● Updated Figure 2–43. 	—
July 2005, v3.1	<ul style="list-style-type: none"> ● Added vertical migration information, including Table 1–4. ● Updated Table 1–5. 	—
May 2005, v3.0	<ul style="list-style-type: none"> ● Updated “Features” section. ● Updated Table 1–2. 	—
March 2005, v2.1	Updated “Introduction” and “Features” sections.	—
January 2005, v2.0	Added note to Table 1–2.	—
October 2004, v1.2	Updated Tables 1–2, 1–3, and 1–5.	—
July 2004, v1.1	<ul style="list-style-type: none"> ● Updated Tables 1–1 and 1–2. ● Updated “Features” section. 	—
February 2004, v1.0	Added document to the Stratix II Device Handbook.	—

synchronous load, and clock enable control for the register. These LAB-wide signals are available in all ALM modes. See the “[LAB Control Signals](#)” section for more information on the LAB-wide control signals.

The Quartus II software and supported third-party synthesis tools, in conjunction with parameterized functions such as library of parameterized modules (LPM) functions, automatically choose the appropriate mode for common functions such as counters, adders, subtractors, and arithmetic functions. If required, you can also create special-purpose functions that specify which ALM operating mode to use for optimal performance.

Normal Mode

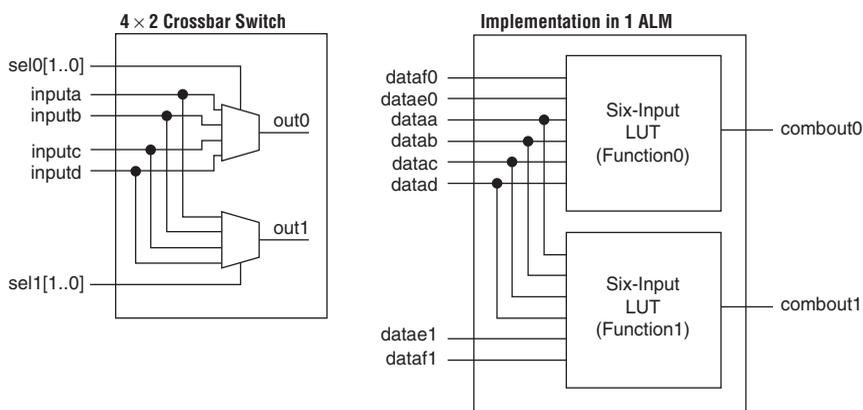
The normal mode is suitable for general logic applications and combinational functions. In this mode, up to eight data inputs from the LAB local interconnect are inputs to the combinational logic. The normal mode allows two functions to be implemented in one Stratix II ALM, or an ALM to implement a single function of up to six inputs. The ALM can support certain combinations of completely independent functions and various combinations of functions which have common inputs.

[Figure 2-7](#) shows the supported LUT combinations in normal mode.

For the packing of two five-input functions into one ALM, the functions must have at least two common inputs. The common inputs are `dataaa` and `datab`. The combination of a four-input function with a five-input function requires one common input (either `dataaa` or `datab`).

In the case of implementing two six-input functions in one ALM, four inputs must be shared and the combinational function must be the same. For example, a 4×2 crossbar switch (two 4-to-1 multiplexers with common inputs and unique select lines) can be implemented in one ALM, as shown in [Figure 2-8](#). The shared inputs are `dataaa`, `datab`, `datac`, and `datad`, while the unique select lines are `datae0` and `dataf0` for `function0`, and `datae1` and `dataf1` for `function1`. This crossbar switch consumes four LUTs in a four-input LUT-based architecture.

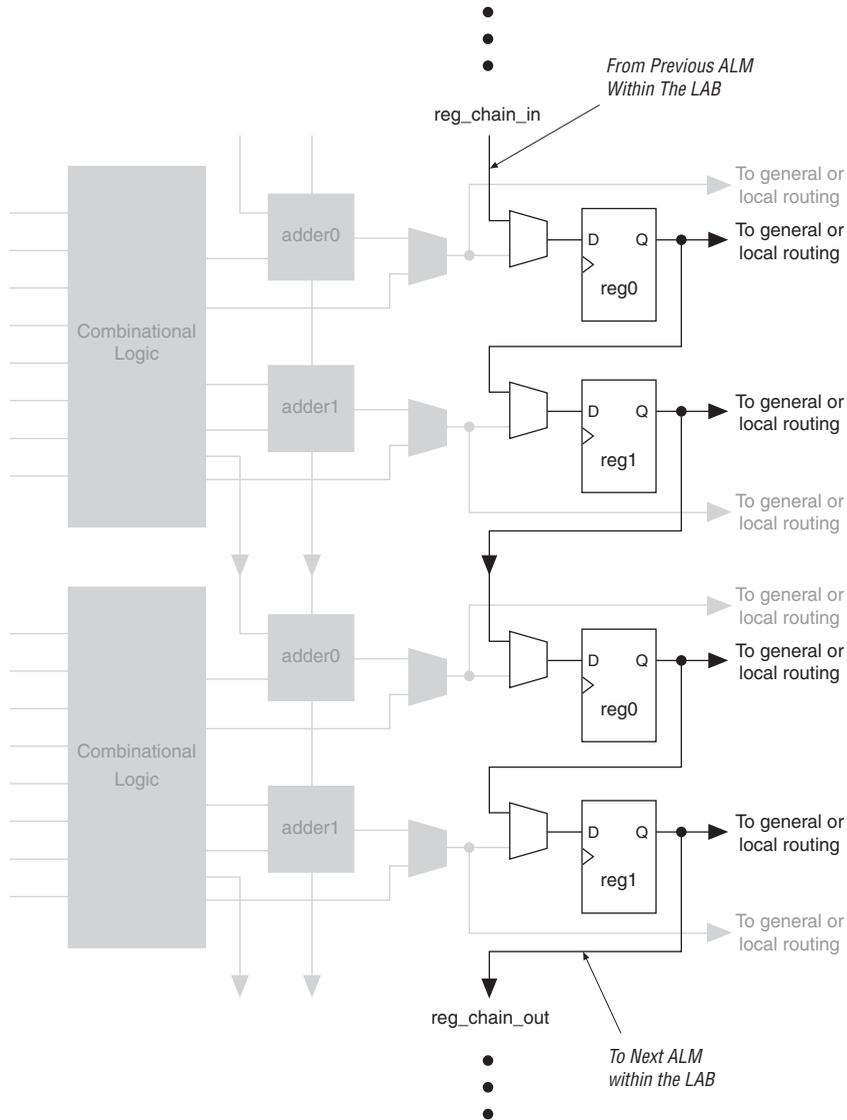
Figure 2-8. 4×2 Crossbar Switch Example



In a sparsely used device, functions that could be placed into one ALM may be implemented in separate ALMs. The Quartus II Compiler spreads a design out to achieve the best possible performance. As a device begins to fill up, the Quartus II software automatically utilizes the full potential of the Stratix II ALM. The Quartus II Compiler automatically searches for functions of common inputs or completely independent functions to be placed into one ALM and to make efficient use of the device resources. In addition, you can manually control resource usage by setting location assignments.

Any six-input function can be implemented utilizing inputs `dataaa`, `datab`, `datac`, `datad`, and either `datae0` and `dataf0` or `datae1` and `dataf1`. If `datae0` and `dataf0` are utilized, the output is driven to `register0`, and/or `register0` is bypassed and the data drives out to the interconnect using the top set of output drivers (see [Figure 2-9](#)). If

Figure 2–15. Register Chain within an LAB *Note (1)*



Note to Figure 2–15:

(1) The combinational or adder logic can be utilized to implement an unrelated, un-registered function.

See the “MultiTrack Interconnect” on page 2–22 section for more information on register chain interconnect.

Digital Signal Processing Block

The most commonly used DSP functions are FIR filters, complex FIR filters, IIR filters, fast Fourier transform (FFT) functions, direct cosine transform (DCT) functions, and correlators. All of these use the multiplier as the fundamental building block. Additionally, some applications need specialized operations such as multiply-add and multiply-accumulate operations. Stratix II devices provide DSP blocks to meet the arithmetic requirements of these functions.

Each Stratix II device has from two to four columns of DSP blocks to efficiently implement DSP functions faster than ALM-based implementations. Stratix II devices have up to 24 DSP blocks per column (see [Table 2-5](#)). Each DSP block can be configured to support up to:

- Eight 9×9 -bit multipliers
- Four 18×18 -bit multipliers
- One 36×36 -bit multiplier

As indicated, the Stratix II DSP block can support one 36×36 -bit multiplier in a single DSP block. This is true for any combination of signed, unsigned, or mixed sign multiplications.



This list only shows functions that can fit into a single DSP block. Multiple DSP blocks can support larger multiplication functions.

The LAB row source for control signals, data inputs, and outputs is shown in [Table 2-7](#).

LAB Row at Interface	Control Signals Generated	Data Inputs	Data Outputs
0	clock0 aclr0 ena0 mult01_saturate addnsub1_round/ accum_round addnsub1 signa sourcea sourceb	A1[17..0] B1[17..0]	OA[17..0] OB[17..0]
1	clock1 aclr1 ena1 accum_saturate mult01_round accum_sload sourcea sourceb mode0	A2[17..0] B2[17..0]	OC[17..0] OD[17..0]
2	clock2 aclr2 ena2 mult23_saturate addnsub3_round/ accum_round addnsub3 sign_b sourcea sourceb	A3[17..0] B3[17..0]	OE[17..0] OF[17..0]
3	clock3 aclr3 ena3 accum_saturate mult23_round accum_sload sourcea sourceb mode1	A4[17..0] B4[17..0]	OG[17..0] OH[17..0]



See the *DSP Blocks in Stratix II & Stratix II GX Devices* chapter in volume 2 of the *Stratix II Device Handbook* or the *Stratix II GX Device Handbook*, for more information on DSP blocks.

Table 2–19. Board Design Recommendations for nCEO

nCE Input Buffer Power in I/O Bank 3	Stratix II nCEO V_{CCIO} Voltage Level in I/O Bank 7				
	$V_{CCIO} = 3.3\text{ V}$	$V_{CCIO} = 2.5\text{ V}$	$V_{CCIO} = 1.8\text{ V}$	$V_{CCIO} = 1.5\text{ V}$	$V_{CCIO} = 1.2\text{ V}$
VCCSEL high (V_{CCIO} Bank 3 = 1.5 V)	✓ (1), (2)	✓ (3), (4)	✓ (5)	✓	✓
VCCSEL high (V_{CCIO} Bank 3 = 1.8 V)	✓ (1), (2)	✓ (3), (4)	✓	✓	Level shifter required
VCCSEL low (nCE Powered by $V_{CCPD} = 3.3\text{V}$)	✓	✓ (4)	✓ (6)	Level shifter required	Level shifter required

Notes to Table 2–19:

- (1) Input buffer is 3.3-V tolerant.
- (2) The nCEO output buffer meets V_{OH} (MIN) = 2.4 V.
- (3) Input buffer is 2.5-V tolerant.
- (4) The nCEO output buffer meets V_{OH} (MIN) = 2.0 V.
- (5) Input buffer is 1.8-V tolerant.
- (6) An external 250- Ω pull-up resistor is not required, but recommended if signal levels on the board are not optimal.

For JTAG chains, the TDO pin of the first device drives the TDI pin of the second device in the chain. The V_{CCSEL} input on JTAG input I/O cells (TCK, TMS, TDI, and TRST) is internally hardwired to GND selecting the 3.3-V/2.5-V input buffer powered by V_{CCPD} . The ideal case is to have the V_{CCIO} of the TDO bank from the first device to match the V_{CCSEL} settings for TDI on the second device, but that may not be possible depending on the application. Table 2–20 contains board design recommendations to ensure proper JTAG chain operation.

Table 2–20. Supported TDO/TDI Voltage Combinations (Part 1 of 2)

Device	TDI Input Buffer Power	Stratix II TDO V_{CCIO} Voltage Level in I/O Bank 4				
		$V_{CCIO} = 3.3\text{ V}$	$V_{CCIO} = 2.5\text{ V}$	$V_{CCIO} = 1.8\text{ V}$	$V_{CCIO} = 1.5\text{ V}$	$V_{CCIO} = 1.2\text{ V}$
Stratix II	Always V_{CCPD} (3.3V)	✓ (1)	✓ (2)	✓ (3)	Level shifter required	Level shifter required

you need to support configuration input voltages of 1.8 V/1.5 V, you should set the VCCSEL to a logic high and the V_{CCIO} of the bank that contains the configuration inputs to 1.8 V/1.5 V.



For more information on multi-volt support, including information on using TDO and nCEO in multi-volt systems, refer to the *Stratix II Architecture* chapter in volume 1 of the *Stratix II Device Handbook*.

Configuration Schemes

You can load the configuration data for a Stratix II device with one of five configuration schemes (see [Table 3–5](#)), chosen on the basis of the target application. You can use a configuration device, intelligent controller, or the JTAG port to configure a Stratix II device. A configuration device can automatically configure a Stratix II device at system power-up.

You can configure multiple Stratix II devices in any of the five configuration schemes by connecting the configuration enable (nCE) and configuration enable output (nCEO) pins on each device.

Stratix II FPGAs offer the following:

- Configuration data decompression to reduce configuration file storage
- Design security using configuration data encryption to protect your designs
- Remote system upgrades for remotely updating your Stratix II designs

[Table 3–5](#) summarizes which configuration features can be used in each configuration scheme.

Configuration Scheme	Configuration Method	Design Security	Decompression	Remote System Upgrade
FPP	MAX II device or microprocessor and flash device	✓ (1)	✓ (1)	✓
	Enhanced configuration device		✓ (2)	✓
AS	Serial configuration device	✓	✓	✓ (3)
PS	MAX II device or microprocessor and flash device	✓	✓	✓
	Enhanced configuration device	✓	✓	✓
	Download cable (4)	✓	✓	

Table 3–7. Document Revision History (Part 2 of 2)

Date and Document Version	Changes Made	Summary of Changes
April 2006, v4.1	Updated “Device Security Using Configuration Bitstream Encryption” section.	—
December 2005, v4.0	Updated “Software Interface” section.	—
May 2005, v3.0	<ul style="list-style-type: none"> ● Updated “IEEE Std. 1149.1 JTAG Boundary-Scan Support” section. ● Updated “Operating Modes” section. 	—
January 2005, v2.1	Updated JTAG chain device limits.	—
January 2005, v2.0	Updated Table 3–3.	—
July 2004, v1.1	<ul style="list-style-type: none"> ● Added “Automated Single Event Upset (SEU) Detection” section. ● Updated “Device Security Using Configuration Bitstream Encryption” section. ● Updated Figure 3–2. 	—
February 2004, v1.0	Added document to the Stratix II Device Handbook.	—

Table 5–14. 3.3-V PCI Specifications (Part 2 of 2)

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V _{IL}	Low-level input voltage		–0.3		0.3 × V _{CCIO}	V
V _{OH}	High-level output voltage	I _{OUT} = –500 μA	0.9 × V _{CCIO}			V
V _{OL}	Low-level output voltage	I _{OUT} = 1,500 μA			0.1 × V _{CCIO}	V

Table 5–15. PCI-X Mode 1 Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V _{CCIO}	Output supply voltage		3.0		3.6	V
V _{IH}	High-level input voltage		0.5 × V _{CCIO}		V _{CCIO} + 0.5	V
V _{IL}	Low-level input voltage		–0.30		0.35 × V _{CCIO}	V
V _{IPU}	Input pull-up voltage		0.7 × V _{CCIO}			V
V _{OH}	High-level output voltage	I _{OUT} = –500 μA	0.9 × V _{CCIO}			V
V _{OL}	Low-level output voltage	I _{OUT} = 1,500 μA			0.1 × V _{CCIO}	V

Table 5–16. SSTL-18 Class I Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V _{CCIO}	Output supply voltage		1.71	1.80	1.89	V
V _{REF}	Reference voltage		0.855	0.900	0.945	V
V _{TT}	Termination voltage		V _{REF} – 0.04	V _{REF}	V _{REF} + 0.04	V
V _{IH} (DC)	High-level DC input voltage		V _{REF} + 0.125			V
V _{IL} (DC)	Low-level DC input voltage				V _{REF} – 0.125	V
V _{IH} (AC)	High-level AC input voltage		V _{REF} + 0.25			V
V _{IL} (AC)	Low-level AC input voltage				V _{REF} – 0.25	V
V _{OH}	High-level output voltage	I _{OH} = –6.7 mA (1)	V _{TT} + 0.475			V
V _{OL}	Low-level output voltage	I _{OL} = 6.7 mA (1)			V _{TT} – 0.475	V

Note to Table 5–16:

- (1) This specification is supported across all the programmable drive settings available for this I/O standard as shown in the *Stratix II Architecture* chapter in volume 1 of the *Stratix II Device Handbook*.

Table 5–17. SSTL-18 Class II Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V_{CCIO}	Output supply voltage		1.71	1.80	1.89	V
V_{REF}	Reference voltage		0.855	0.900	0.945	V
V_{TT}	Termination voltage		$V_{REF} - 0.04$	V_{REF}	$V_{REF} + 0.04$	V
$V_{IH} (DC)$	High-level DC input voltage		$V_{REF} + 0.125$			V
$V_{IL} (DC)$	Low-level DC input voltage				$V_{REF} - 0.125$	V
$V_{IH} (AC)$	High-level AC input voltage		$V_{REF} + 0.25$			V
$V_{IL} (AC)$	Low-level AC input voltage				$V_{REF} - 0.25$	V
V_{OH}	High-level output voltage	$I_{OH} = -13.4 \text{ mA}$ (1)	$V_{CCIO} - 0.28$			V
V_{OL}	Low-level output voltage	$I_{OL} = 13.4 \text{ mA}$ (1)			0.28	V

Note to Table 5–17:

- (1) This specification is supported across all the programmable drive settings available for this I/O standard as shown in the *Stratix II Architecture* chapter in volume 1 of the *Stratix II Device Handbook*.

Table 5–18. SSTL-18 Class I & II Differential Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V_{CCIO}	Output supply voltage		1.71	1.80	1.89	V
$V_{SWING} (DC)$	DC differential input voltage		0.25			V
$V_X (AC)$	AC differential input cross point voltage		$(V_{CCIO}/2) - 0.175$		$(V_{CCIO}/2) + 0.175$	V
$V_{SWING} (AC)$	AC differential input voltage		0.5			V
V_{ISO}	Input clock signal offset voltage			$0.5 \times V_{CCIO}$		V
ΔV_{ISO}	Input clock signal offset voltage variation			± 200		mV
$V_{OX} (AC)$	AC differential cross point voltage		$(V_{CCIO}/2) - 0.125$		$(V_{CCIO}/2) + 0.125$	V

Table 5–30. Series On-Chip Termination Specification for Top & Bottom I/O Banks (Part 2 of 2)
Notes (1), 2

Symbol	Description	Conditions	Resistance Tolerance		
			Commercial Max	Industrial Max	Unit
50-Ω R _S 3.3/2.5	Internal series termination with calibration (50-Ω setting)	V _{CCIO} = 3.3/2.5 V	±5	±10	%
	Internal series termination without calibration (50-Ω setting)	V _{CCIO} = 3.3/2.5 V	±30	±30	%
50-Ω R _T 2.5	Internal parallel termination with calibration (50-Ω setting)	V _{CCIO} = 1.8 V	±30	±30	%
25-Ω R _S 1.8	Internal series termination with calibration (25-Ω setting)	V _{CCIO} = 1.8 V	±5	±10	%
	Internal series termination without calibration (25-Ω setting)	V _{CCIO} = 1.8 V	±30	±30	%
50-Ω R _S 1.8	Internal series termination with calibration (50-Ω setting)	V _{CCIO} = 1.8 V	±5	±10	%
	Internal series termination without calibration (50-Ω setting)	V _{CCIO} = 1.8 V	±30	±30	%
50-Ω R _T 1.8	Internal parallel termination with calibration (50-Ω setting)	V _{CCIO} = 1.8 V	±10	±15	%
50-Ω R _S 1.5	Internal series termination with calibration (50-Ω setting)	V _{CCIO} = 1.5 V	±8	±10	%
	Internal series termination without calibration (50-Ω setting)	V _{CCIO} = 1.5 V	±36	±36	%
50-Ω R _T 1.5	Internal parallel termination with calibration (50-Ω setting)	V _{CCIO} = 1.5 V	±10	±15	%
50-Ω R _S 1.2	Internal series termination with calibration (50-Ω setting)	V _{CCIO} = 1.2 V	±8	±10	%
	Internal series termination without calibration (50-Ω setting)	V _{CCIO} = 1.2 V	±50	±50	%
50-Ω R _T 1.2	Internal parallel termination with calibration (50-Ω setting)	V _{CCIO} = 1.2 V	±10	±15	%

Notes for Table 5–30:

- (1) The resistance tolerances for calibrated SOCT and POCT are for the moment of calibration. If the temperature or voltage changes over time, the tolerance may also change.
- (2) On-chip parallel termination with calibration is only supported for input pins.

Table 5–75. Stratix II I/O Output Delay for Column Pins (Part 4 of 8)

I/O Standard	Drive Strength	Parameter	Minimum Timing		-3 Speed Grade (3)	-3 Speed Grade (4)	-4 Speed Grade	-5 Speed Grade	Unit	
			Industrial	Commercial						
SSTL-18 Class I	4 mA	t _{OP}	909	953	1690	1773	1942	2012	ps	
		t _{DIP}	929	975	1756	1843	2018	2102	ps	
	6 mA	t _{OP}	914	958	1656	1737	1903	1973	ps	
		t _{DIP}	934	980	1722	1807	1979	2063	ps	
	8 mA	t _{OP}	894	937	1640	1721	1885	1954	ps	
		t _{DIP}	914	959	1706	1791	1961	2044	ps	
	10 mA	t _{OP}	898	942	1638	1718	1882	1952	ps	
		t _{DIP}	918	964	1704	1788	1958	2042	ps	
	12 mA (1)	t _{OP}	891	936	1626	1706	1869	1938	ps	
		t _{DIP}	911	958	1692	1776	1945	2028	ps	
	SSTL-18 Class II	8 mA	t _{OP}	883	925	1597	1675	1835	1904	ps
			t _{DIP}	903	947	1663	1745	1911	1994	ps
16 mA		t _{OP}	894	937	1578	1655	1813	1882	ps	
		t _{DIP}	914	959	1644	1725	1889	1972	ps	
18 mA		t _{OP}	890	933	1585	1663	1821	1890	ps	
		t _{DIP}	910	955	1651	1733	1897	1980	ps	
20 mA (1)		t _{OP}	890	933	1583	1661	1819	1888	ps	
		t _{DIP}	910	955	1649	1731	1895	1978	ps	
1.8-V HSTL Class I		4 mA	t _{OP}	912	956	1608	1687	1848	1943	ps
			t _{DIP}	932	978	1674	1757	1924	2033	ps
	6 mA	t _{OP}	917	962	1595	1673	1833	1928	ps	
		t _{DIP}	937	984	1661	1743	1909	2018	ps	
	8 mA	t _{OP}	896	940	1586	1664	1823	1917	ps	
		t _{DIP}	916	962	1652	1734	1899	2007	ps	
	10 mA	t _{OP}	900	944	1591	1669	1828	1923	ps	
		t _{DIP}	920	966	1657	1739	1904	2013	ps	
	12 mA (1)	t _{OP}	892	936	1585	1663	1821	1916	ps	
		t _{DIP}	912	958	1651	1733	1897	2006	ps	

Table 5–75. Stratix II I/O Output Delay for Column Pins (Part 5 of 8)

I/O Standard	Drive Strength	Parameter	Minimum Timing		-3 Speed Grade (3)	-3 Speed Grade (4)	-4 Speed Grade	-5 Speed Grade	Unit	
			Industrial	Commercial						
1.8-V HSTL Class II	16 mA	t_{OP}	877	919	1385	1453	1591	1680	ps	
		t_{DIP}	897	941	1451	1523	1667	1770	ps	
	18 mA	t_{OP}	879	921	1394	1462	1602	1691	ps	
		t_{DIP}	899	943	1460	1532	1678	1781	ps	
	20 mA (1)	t_{OP}	879	921	1402	1471	1611	1700	ps	
		t_{DIP}	899	943	1468	1541	1687	1790	ps	
1.5-V HSTL Class I	4 mA	t_{OP}	912	956	1607	1686	1847	1942	ps	
		t_{DIP}	932	978	1673	1756	1923	2032	ps	
	6 mA	t_{OP}	917	961	1588	1666	1825	1920	ps	
		t_{DIP}	937	983	1654	1736	1901	2010	ps	
	8 mA	t_{OP}	899	943	1590	1668	1827	1922	ps	
		t_{DIP}	919	965	1656	1738	1903	2012	ps	
	10 mA	t_{OP}	900	943	1592	1670	1829	1924	ps	
		t_{DIP}	920	965	1658	1740	1905	2014	ps	
	12 mA (1)	t_{OP}	893	937	1590	1668	1827	1922	ps	
		t_{DIP}	913	959	1656	1738	1903	2012	ps	
	1.5-V HSTL Class II	16 mA	t_{OP}	881	924	1431	1501	1644	1734	ps
			t_{DIP}	901	946	1497	1571	1720	1824	ps
18 mA		t_{OP}	884	927	1439	1510	1654	1744	ps	
		t_{DIP}	904	949	1505	1580	1730	1834	ps	
20 mA (1)		t_{OP}	886	929	1450	1521	1666	1757	ps	
		t_{DIP}	906	951	1516	1591	1742	1847	ps	
1.2-V HSTL		t_{OP}	958	1004	1602	1681	-	-	ps	
		t_{DIP}	978	1026	1668	1751	-	-	ps	
PCI		t_{OP}	1028	1082	1956	2051	2244	2070	ps	
		t_{DIP}	1048	1104	2022	2121	2320	2160	ps	
PCI-X		t_{OP}	1028	1082	1956	2051	2244	2070	ps	
		t_{DIP}	1048	1104	2022	2121	2320	2160	ps	

Table 5–78. Maximum Output Toggle Rate on Stratix II Devices (Part 1 of 5) *Note (1)*

I/O Standard	Drive Strength	Column I/O Pins (MHz)			Row I/O Pins (MHz)			Clock Outputs (MHz)		
		-3	-4	-5	-3	-4	-5	-3	-4	-5
3.3-V LVTTTL	4 mA	270	225	210	270	225	210	270	225	210
	8 mA	435	355	325	435	355	325	435	355	325
	12 mA	580	475	420	580	475	420	580	475	420
	16 mA	720	594	520	-	-	-	720	594	520
	20 mA	875	700	610	-	-	-	875	700	610
	24 mA	1,030	794	670	-	-	-	1,030	794	670
3.3-V LVCMOS	4 mA	290	250	230	290	250	230	290	250	230
	8 mA	565	480	440	565	480	440	565	480	440
	12 mA	790	710	670	-	-	-	790	710	670
	16 mA	1,020	925	875	-	-	-	1,020	925	875
	20 mA	1,066	985	935	-	-	-	1,066	985	935
	24 mA	1,100	1,040	1,000	-	-	-	1,100	1,040	1,000
2.5-V LVTTTL/LVCMOS	4 mA	230	194	180	230	194	180	230	194	180
	8 mA	430	380	380	430	380	380	430	380	380
	12 mA	630	575	550	630	575	550	630	575	550
	16 mA	930	845	820	-	-	-	930	845	820
1.8-V LVTTTL/LVCMOS	2 mA	120	109	104	120	109	104	120	109	104
	4 mA	285	250	230	285	250	230	285	250	230
	6 mA	450	390	360	450	390	360	450	390	360
	8 mA	660	570	520	660	570	520	660	570	520
	10 mA	905	805	755	-	-	-	905	805	755
	12 mA	1,131	1,040	990	-	-	-	1,131	1,040	990
1.5-V LVTTTL/LVCMOS	2 mA	244	200	180	244	200	180	244	200	180
	4 mA	470	370	325	470	370	325	470	370	325
	6 mA	550	430	375	-	-	-	550	430	375
	8 mA	625	495	420	-	-	-	625	495	420
SSTL-2 Class I	8 mA	400	300	300	-	-	-	400	300	300
	12 mA	400	400	350	400	350	350	400	400	350
SSTL-2 Class II	16 mA	350	350	300	350	350	300	350	350	300
	20 mA	400	350	350	-	-	-	400	350	350
	24 mA	400	400	350	-	-	-	400	400	350

Table 5–78. Maximum Output Toggle Rate on Stratix II Devices (Part 5 of 5) *Note (1)*

I/O Standard	Drive Strength	Column I/O Pins (MHz)			Row I/O Pins (MHz)			Clock Outputs (MHz)		
		-3	-4	-5	-3	-4	-5	-3	-4	-5
1.2-V Differential HSTL	OCT 50 Ω	280	-	-	-	-	-	280	-	-

Notes to Table 5–78:

- (1) The toggle rate applies to 0-pF output load for all I/O standards except for LVDS and HyperTransport technology on row I/O pins. For LVDS and HyperTransport technology on row I/O pins, the toggle rates apply to load from 0 to 5pF.
- (2) 1.2-V HSTL is only supported on column I/O pins in I/O banks 4, 7, and 8.
- (3) Differential HSTL and SSTL is only supported on column clock and DQS outputs.
- (4) HyperTransport technology is only supported on row I/O and row dedicated clock input pins.
- (5) LVPECL is only supported on column clock pins.
- (6) Refer to Tables 5–81 through 5–91 if using SERDES block. Use the toggle rate values from the clock output column for PLL output.

Table 5–79. Maximum Output Clock Toggle Rate Derating Factors (Part 1 of 5)

I/O Standard	Drive Strength	Maximum Output Clock Toggle Rate Derating Factors (ps/pF)								
		Column I/O Pins			Row I/O Pins			Dedicated Clock Outputs		
		-3	-4	-5	-3	-4	-5	-3	-4	-5
3.3-V LVTTTL	4 mA	478	510	510	478	510	510	466	510	510
	8 mA	260	333	333	260	333	333	291	333	333
	12 mA	213	247	247	213	247	247	211	247	247
	16 mA	136	197	197	-	-	-	166	197	197
	20 mA	138	187	187	-	-	-	154	187	187
	24 mA	134	177	177	-	-	-	143	177	177
3.3-V LVCMOS	4 mA	377	391	391	377	391	391	377	391	391
	8 mA	206	212	212	206	212	212	178	212	212
	12 mA	141	145	145	-	-	-	115	145	145
	16 mA	108	111	111	-	-	-	86	111	111
	20 mA	83	88	88	-	-	-	79	88	88
	24 mA	65	72	72	-	-	-	74	72	72
2.5-V LVTTTL/LVCMOS	4 mA	387	427	427	387	427	427	391	427	427
	8 mA	163	224	224	163	224	224	170	224	224
	12 mA	142	203	203	142	203	203	152	203	203
	16 mA	120	182	182	-	-	-	134	182	182

Table 5–92. Enhanced PLL Specifications (Part 2 of 2)

Name	Description	Min	Typ	Max	Unit
t_{LOCK}	Time required for the PLL to lock from the time it is enabled or the end of device configuration		0.03	1	ms
t_{DLOCK}	Time required for the PLL to lock dynamically after automatic clock switchover between two identical clock frequencies			1	ms
$f_{\text{SWITCHOVER}}$	Frequency range where the clock switchover performs properly	4		500	MHz
f_{CLBW}	PLL closed-loop bandwidth	0.13	1.20	16.90	MHz
f_{VCO}	PLL VCO operating range for –3 and –4 speed grade devices	300		1,040	MHz
	PLL VCO operating range for –5 speed grade devices	300		840	MHz
f_{SS}	Spread-spectrum modulation frequency	30		150	kHz
% spread	Percent down spread for a given clock frequency	0.4	0.5	0.6	%
$t_{\text{PLL_PSERR}}$	Accuracy of PLL phase shift			±15	ps
t_{ARESET}	Minimum pulse width on <code>areset</code> signal.	10			ns
$t_{\text{ARESET_RECONFIG}}$	Minimum pulse width on the <code>areset</code> signal when using PLL reconfiguration. Reset the PLL after <code>scandone</code> goes high.	500			ns

Notes to Table 5–92:

- (1) Limited by I/O f_{MAX} . See Table 5–78 on page 5–69 for the maximum. Cannot exceed f_{OUT} specification.
- (2) If the counter cascading feature of the PLL is utilized, there is no minimum output clock frequency.